



#### N-CHANNEL ENHANCEMENT MODE MOSFET

## **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub> T <sub>A</sub> = +25°C
001/	2Ω @ V <sub>GS</sub> = 4V	320mA
60V	2.5Ω @ V <sub>GS</sub> = 2.5V	50mA

## **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

## **Description and Applications**

This new generation MOSFET is designed to minimize the on-state resistance ( $R_{DS(ON)}$ ) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

- DC-DC Converters
- Power Management Functions
- Battery Operated Systems and Solid-State Relays
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc.

#### **Mechanical Data**

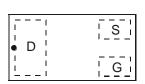
- Case: X1-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound;
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe.
  Solderable per MIL-STD-202, Method 208 @4
- Weight: 0.001 grams (Approximate)



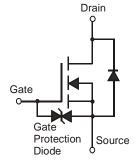


X1-DFN1006-3

**Bottom View** 



Top View Pin-Out



**Equivalent Circuit** 

## Ordering Information (Note 4)

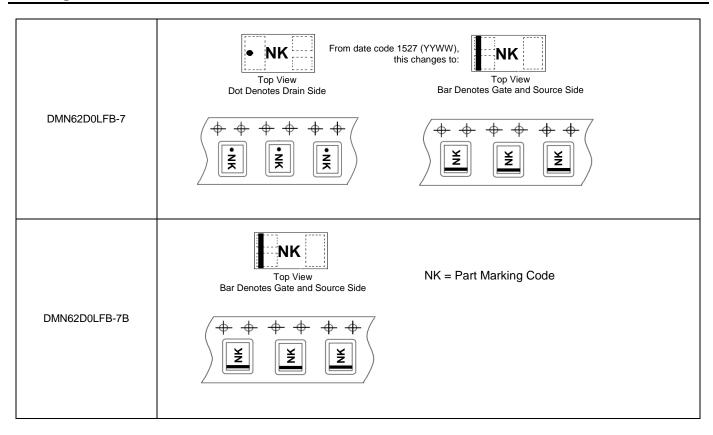
Product	Marking	Reel Size (inches)	Tape Width (mm)	Quantity per Reel
DMN62D0LFB-7	NK	7	8	3,000
DMN62D0LFB-7B	NK	7	8	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.



# **Marking Information**



# **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Character	Symbol	Value	Unit		
Drain-Source Voltage	V <sub>DSS</sub>	60	V		
Gate-Source Voltage	V <sub>GSS</sub>	±20	V		
Continuous Drain Current (Note 5) V <sub>GS</sub> = 4.0V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	320 75	mA
Pulsed Drain Current (Note 6)	I <sub>DM</sub>	1	Α		

## **Thermal Characteristics**

Characteristic	Symbol	Max	Unit
Power Dissipation (Note 5)	P <sub>D</sub>	0.5	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C (Note 5)	$R_{\theta JA}$	258	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

Notes: 5. Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.

6. Repetitive rating, pulse width limited by junction temperature.

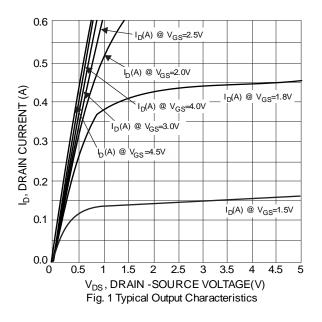


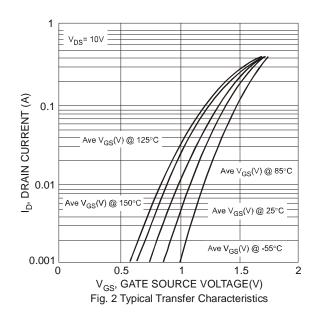
# Electrical Characteristics (@ T<sub>A</sub> = +25°C, unless otherwise stated.)

Characteristic		Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	-	-	1.0	μΑ	$V_{DS} = 60V, V_{GS} = 0V$	
		-	-	±100	nA	$V_{GS} = \pm 5V$ , $V_{DS} = 0V$	
Gate-Source Leakage	$I_{GSS}$	-	-	±500	nA	$V_{GS} = \pm 10V, V_{DS} = 0V$	
		-	-	±2.0	μΑ	$V_{GS} = \pm 15V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	0.6	-	1.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
	R <sub>DS(ON)</sub>	-	1.3	2		$V_{GS} = 4V, I_{D} = 100mA$	
Static Drain-Source On-Resistance		-	1.5	2.5	Ω	$V_{GS} = 2.5V, I_D = 50mA$	
Static Dialii-Source Off-Resistance		-	1.9	3	Ω	$V_{GS} = 1.8V, I_D = 50mA$	
		-	2.6	-		$V_{GS} = 1.5V, I_D = 10mA$	
Forward Transfer Admittance	Y <sub>fs</sub>	-	8.0	-	S	$V_{DS} = 10V, I_{D} = 200mA$	
Diode Forward Voltage	$V_{SD}$	-	0.9	1.3	V	$V_{GS} = 0V, I_{S} = 115mA$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss	-	32	64		)/ OF)/ )/ O)/	
Output Capacitance	Coss	-	4.4	9	pF	$V_{DS} = 25V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	-	2.9	6		I = 1.0IVIHZ	
Gate Resistance	$R_g$	-	126	250	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge	Qg	-	0.45	0.9		V 45V V 40V	
Gate-Source Charge	Qgs	-	0.08	0.2	nC	$V_{GS} = 4.5V, V_{DS} = 10V,$ $I_{D} = 250mA$	
Gate-Drain Charge	$Q_{gd}$	-	0.08	0.2			
Turn-On Delay Time	t <sub>D(ON)</sub>	-	3.4	10	ns	101/1/	
Turn-On Rise Time	t <sub>R</sub>	-	3.4	10	ns	$V_{GS} = 10V, V_{DS} = 30V,$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	-	26.4	45	ns	$R_L = 150\Omega$ , $R_g = 25\Omega$ ,	
Turn-Off Fall Time	t <sub>F</sub>	-	16.3	30	ns	$I_D = 200 \text{mA}$	

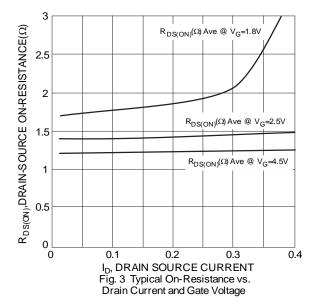
Notes:

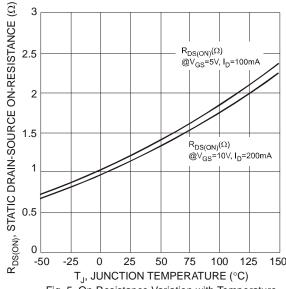
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.

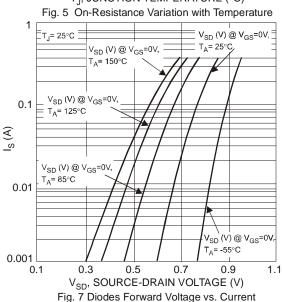


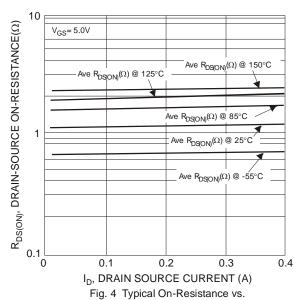






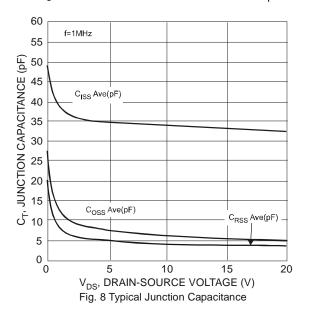




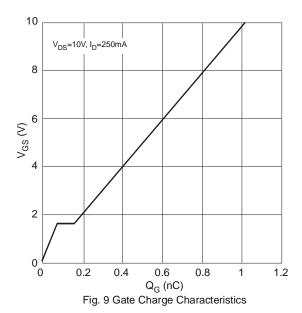


Drain Current and Temperature 1.6  $V_{TH}(V) @ I_D=1mA$ V<sub>TH</sub>, GATE THRESHOLD VOLTAGE (V) 1.2 8.0 0.6 0.2 -50 -25 0 25 50 75 100 125 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Fig. 6 Gate Threshold Variation vs. Junction Temperature







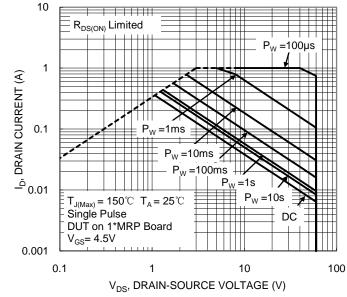


Fig.10 SOA, Safe Operation Area

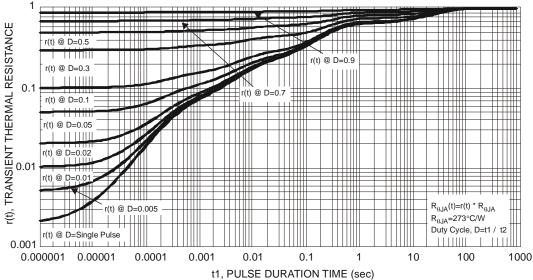
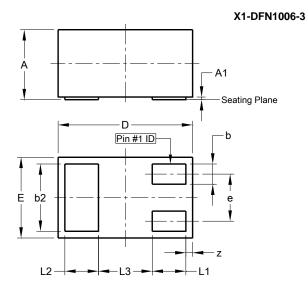


Fig. 11 Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

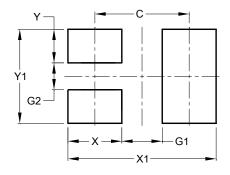


X1-DFN1006-3				
Dim	Min	Max	Тур	
Α	0.47	0.53	0.50	
A1	0.00	0.05	0.03	
b	0.10	0.20	0.15	
b2	0.45	0.55	0.50	
ם	0.95	1.075	1.00	
E	0.55	0.675	0.60	
e	ı	-	0.35	
L1	0.20	0.30	0.25	
L2	0.20	0.30	0.25	
L3	-	-	0.40	
Z	0.02	0.08	0.05	
All Dimensions in mm				

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### X1-DFN1006-3



Dimensions	Value (in mm)
С	0.70
G1	0.30
G2	0.20
Х	0.40
X1	1.10
Y	0.25
Y1	0.70



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